

Search Notes

Application/Control No.

10/827,224

Examiner

Hau V. Phan

Applicant(s)/Patent under
Reexamination

CHUNG, CHARLES

Art Unit

3618

SEARCHED

Class	Subclass	Date	Examiner
280	87.041 87.042 87.05	8/31/2005	HP
	282		
	256		
	14.28		
	7.12		
	87.021		
D21	423	8/31/2005	HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search	8/31/2005	HP